

INTERNATIONAL STANDARD

NORME INTERNATIONALE



**Specification for the testing of balanced and coaxial information technology cabling –
Part 1: Installed balanced cabling as specified in ISO/IEC 11801 and related standards**

**Spécification relative aux essais des câblages symétriques et coaxiaux des technologies de l'information –
Partie 1: Câblages symétriques installés conformément à l'ISO/IEC 11801 et normes associées**



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